

Search Notes

Application/Control No.

10/691,191

Examiner

John L. Goodrow

Applicant(s)/Patent under
Reexamination

QIAN ET AL.

Art Unit

1756

SEARCHED

Class	Subclass	Date	Examiner
430	115	5/31/2005	JG
	114		
	117		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
inventor name search	5/31/2005	JG